

Search Notes

Application/Control No.

10/649,671

Examiner

Hong C. Kim

Applicant(s)/Patent under
Reexamination

HIRAIWA ET AL.

Art Unit

2185

SEARCHED

Class	Subclass	Date	Examiner
See Attached		1/20/06	IdK

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See Attached		1/20/06	IdK

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	1/20/06	IdK